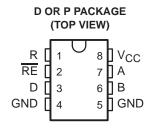
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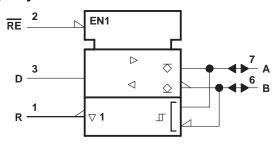
- Bidirectional Transceiver
- Designed for Multipoint Transmission in Noisy Environments Such as Automotive Applications
- 3-State Driver and Receiver Outputs
- Individual Driver and Receiver Enables
- Wide Positive and Negative Input/Output Bus Voltage Ranges
- Driver Output Capability . . . ±10 mA Max
- Thermal Shutdown Protection
- Driver Positive and Negative Current Limiting
- Receiver Input Impedance . . . 12 kΩ Min
- Receiver Input Sensitivity . . . ±200 mV
- Receiver Input Hysteresis . . . 50 mV Typ
- Operates From Single 5-V Supply
- Low Power Requirements

## description

The SN65076B and SN75076B differential bus transceivers are monolithic integrated circuits designed for bidirectional data communication on multipoint bus transmission lines. They are designed for noisy environments, where a low-impedance termination to ground is required.

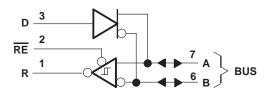


### logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

#### logic diagram (positive logic)



The SN65076B and SN75076B combine a differential line driver and a differential input line receiver, both of which operate from a single 5-V power supply. The receiver has an active-low enable. The driver differential outputs and the receiver differential inputs are connected internally to form differential input/output (I/O) bus ports that are designed to offer minimum loading to the bus whenever the driver is disabled or  $V_{CC} = 0$ . These ports feature wide positive and negative common-mode voltage ranges making the device suitable for party-line applications.

#### **Function Tables**

#### DRIVER

INPUT	OUTPUTS				
D	Α	В			
Н	H <sub>.</sub>	L.			
L	L†	Η <sup>†</sup>			

<sup>†</sup> These levels assume that the open-collector outputs (A) and the open-emitter outputs (B) are connected to a pullup and pulldown resistor, respectively.

#### RECEIVER

DIFFERENTIAL INPUTS A – B	ENABLE RE	OUTPUT R
V <sub>ID</sub> ≥ 0.2 V	L	L
$-0.2 \text{ V} < \text{V}_{\text{ID}} < 0.2 \text{ V}$	L	?
V <sub>ID</sub> ≤ -0.2 V	L	Н
X	Н	Z

H = high level, L = low level, ? = indeterminate;

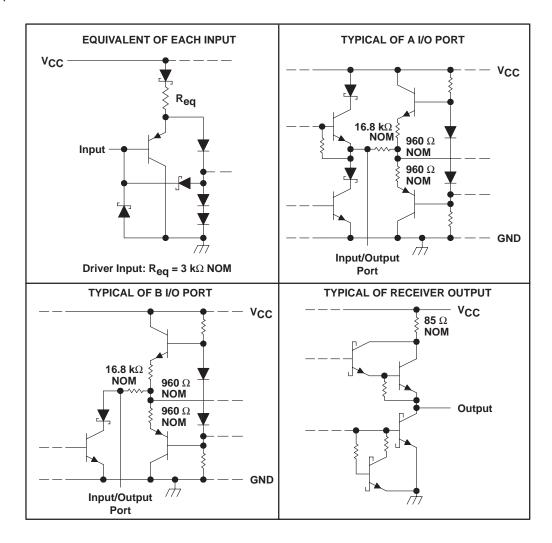
X = irrelevant, Z = high impedance (off)



#### description (continued)

The driver is designed to handle loads up to 10 mA of sink and source current. The driver features positive- and negative-current limiting and thermal shutdown for protection from line fault conditions. Thermal shutdown is designed to occur at a junction temperature of approximately 150°C in the P package and 170°C in the D package. The receiver features a minimum input impedance of 12 k $\Omega$ , an input sensitivity of  $\pm 200$  mV, and a typical input hysteresis of 50 mV.

The SN65076B is characterized for operation from  $-40^{\circ}$ C to  $105^{\circ}$ C and the SN75076B is characterized for operation from  $0^{\circ}$ C to  $70^{\circ}$ C.



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### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V <sub>CC</sub> (see Note 1)	
Voltage range at any bus terminal	10 V to 15 V
Enable input voltage	5.5 V
Continuous total power dissipation	See Dissipation Rating Table
Operating free-air temperature range: SN65076l	3 –40°C to 105°C
SN75076I	3 0°C to 70°C
Storage temperature range	65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from the ca	se for 10 seconds

NOTE 1: All voltage values, except differential input/output bus voltage, are with respect to network ground terminal.

#### **DISSIPATION RATING TABLE**

PACKAGE	$T_{\mbox{A}} \le 25^{\circ}\mbox{C}$ POWER RATING	DERATING FACTOR ABOVE T <sub>A</sub> = 25°C	T <sub>A</sub> = 70°C POWER RATING	T <sub>A</sub> = 105°C POWER RATING
D	725 mW	5.8 mW/°C	464 mW	261 mW
Р	1100 mW	8.8 mW/°C	702 mW	396 mW

## recommended operating conditions

			MIN	NOM	MAX	UNIT
Supply voltage, V <sub>CC</sub>		4.75	5	5.25	V	
Voltage at any bus terminal (separately or common mode), V <sub>I</sub> or V <sub>IC</sub>				12	V	
				-7	V	
High-level input voltage, V <sub>IH</sub>		D and RE	2			V
Low-level input voltage, V <sub>IL</sub>		D and RE			0.8	V
Differential input voltage, V <sub>ID</sub> (see Note 2)				±12	V	
High lovel output ourrent lass		Driver (A)			-10	mA
High-level output current, IOH		Receiver			-400	μΑ
Low-level output current, IOL		Driver (B)			10	mA
		Receiver			8	IIIA
Operating free-air temperature, TA	SN65076B		-40		105	°C
	SN75076B		0		70	C

NOTE 2: Differential-input/output bus voltage is measured at the noninverting terminal A with respect to the inverting terminal B.

#### **DRIVER SECTION**

# electrical characteristics over recommended ranges of supply voltage and operating free-air temperature

	PARAMETER	TE	ST CONDITIONS	MIN	MAX	UNIT
٧ıK	Input clamp voltage	$I_{I} = -18 \text{ mA}$	$I_{I} = -18 \text{ mA}$		-1.5	V
٧o	Output voltage	V <sub>I</sub> = 2 V,	IO = 0	0	6	V
V <sub>OD1</sub>	Differential output voltage	IO = 0		1.5	6	V
V <sub>OD2</sub>	Differential output voltage	See Figure 1		1.5	5	V
10	Output current	V <sub>1</sub> = 0.8 V	V <sub>O</sub> = 12 V		1	mA
10		V  = 0.6 V	$V_0 = -7 \text{ V}$		-0.8	IIIA
lн	High-level input current	V <sub>I</sub> = 2.4 V	V <sub>I</sub> = 2.4 V		20	μΑ
I <sub>I</sub> L	Low-level input current	V <sub>I</sub> = 0.4 V	V <sub>I</sub> = 0.4 V		-400	μΑ
	Short-circuit output current	$V_O = -7 V$	$V_O = -7 V$		-250	
		V <sub>O</sub> = 0	V <sub>O</sub> = 0		-150	mA
los		AO = ACC	VO = VCC		250	IIIA
		V <sub>O</sub> = 12 V	V <sub>O</sub> = 12 V		250	
Icc	Supply current (total package)	No load			30	mA

# switching characteristics, $V_{CC}$ = 5 V, $T_A$ = 25°C

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
ton	Differential-output turn-on time	Coo Figure 2		60	90	ns
toff	Differential-output turn-off time	See Figure 3		75	110	ns

#### **RECEIVER SECTION**

# electrical characteristics over recommended ranges of common-mode input voltage, supply voltage, and operating free-air temperature (unless otherwise noted)

	PARAMETER	TEST CON	IDITIONS	MIN	TYP <sup>†</sup>	MAX	UNIT
V <sub>T+</sub>	Positive-going input threshold voltage	V <sub>O</sub> = 2.7 V,	$I_0 = -0.4 \text{ mA}$			0.2	V
V <sub>T</sub> _	Negative-going input threshold voltage	$V_0 = 0.5 V$ ,	I <sub>O</sub> = 8 mA	-0.2‡			V
V <sub>hys</sub>	Hysteresis (V <sub>T+</sub> – V <sub>T</sub> –)				50		mV
٧ıK	Enable-input clamp voltage	I <sub>I</sub> = –18 mA				-1.5	V
Vон	High-level output voltage	V <sub>ID</sub> = −200 mV, See Figure 2	$I_{OH} = -400 \mu A,$	2.7			٧
VOL	Low-level output voltage	V <sub>ID</sub> = −200 mV, See Figure 2	$I_{OL} = 8 \text{ mA},$			0.45	٧
loz	High-impedance-state output current	V <sub>O</sub> = 0.4 V to 2.4	V			±20	μΑ
1 <sub>1</sub>	Line input current	Other input = 0 V, $V_I = -7 V$ ,	V <sub>I</sub> = 12 V, See Note 3			1 -0.8	mA
lн	High-level enable-input current	V <sub>IH</sub> = 2.7 V				20	μΑ
I <sub>I</sub> L	Low-level enable-input current	V <sub>IL</sub> = 0.4 V				-100	μΑ
rį	Input resistance			12			kΩ
los	Short-circuit output current		·	-15		-85	mA
ICC	Supply current (total package)	No load	·			30	mA

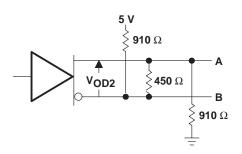
NOTE 3: This applies for both power on and power off.

## switching characteristics, $V_{CC}$ = 5 V, $C_L$ = 15 pF, $T_A$ = 25°C

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
tPLH	Propagation delay time, low-to-high level output	Vin - 0 to 3 V Soo Figure 4		21	35	ns
tPHL	Propagation delay time, high-to-low level output	V <sub>ID</sub> = 0 to 3 V, See Figure 4		23	35	ns
<sup>t</sup> PZH	Output enable time to high level	See Figure 5		10	20	ns
tPZL	Output enable time to low level	See Figure 5		12	20	ns
tPHZ	Output disable time from high level	Coo Figure 5		20	35	ns
t <sub>PLZ</sub>	Output disable time from low level	See Figure 5		17	25	ns

<sup>†</sup> All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C. ‡ The algebraic convention, in which the less-positive (more-negative) limit is designated minimum, is used in this data sheet for threshold voltage levels only.

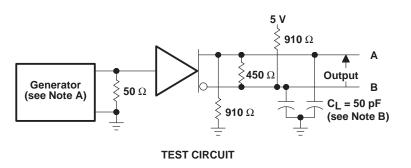
#### PARAMETER MEASUREMENT INFORMATION

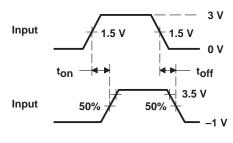


V<sub>ID</sub> V<sub>OH</sub> V<sub>OH</sub>

Figure 1. Driver V<sub>OD2</sub>

Figure 2. Receiver VOH and VOL





**VOLTAGE WAVEFORMS** 

Figure 3. Driver Differential-Output Delay Times

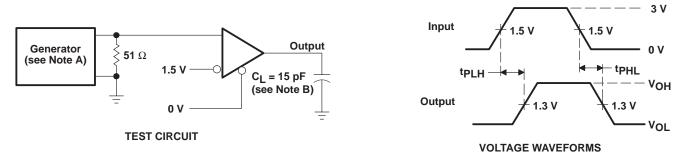
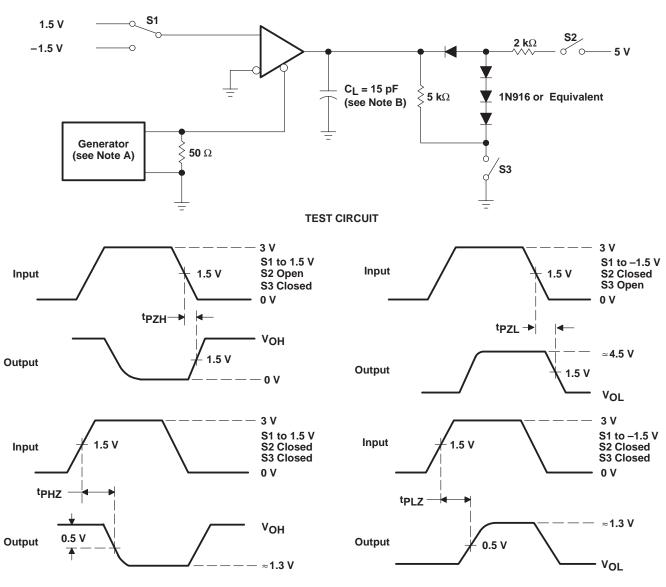


Figure 4. Receiver Test Circuit and Voltage Waveforms Propagation Delay Times

NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  500 kHz, 50% duty cycle,  $t_f \leq$  6 ns,  $t_f \leq$  7 ns,  $t_f \leq$  8 ns,  $t_f \leq$  8 ns,  $t_f \leq$  8 ns,  $t_f \leq$  8 ns,  $t_f \leq$  9 ns,  $t_$ 

B. C<sub>L</sub> includes probe and jig capacitance.

#### PARAMETER MEASUREMENT INFORMATION



**VOLTAGE WAVEFORMS** 

Figure 5. Receiver Output Enable and Disable Times

NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  500 kHz, 50% duty cycle,  $t_f \leq$  6 ns,  $t_f \leq$  8 ns,  $t_f \leq$  8 ns,  $t_f \leq$  9 ns,  $t_$ 

B. CL includes probe and jig capacitance.

#### TYPICAL CHARACTERISTICS

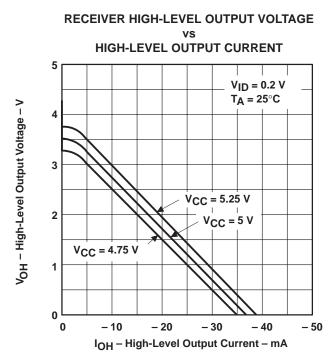
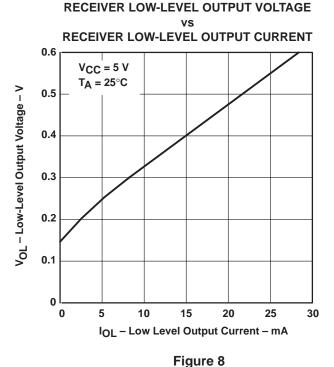


Figure 6



<sup>†</sup> Only the 0°C to 70°C portion of the curve applies for the SN75076B.

# RECEIVER HIGH-LEVEL OUTPUT<sup>†</sup> FREE-AIR TEMPERATURE

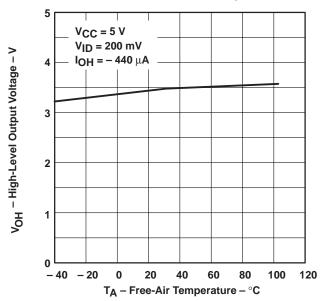


Figure 7

#### RECEIVER LOW-LEVEL OUTPUT VOLTAGE† vs

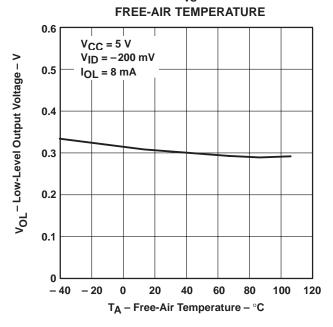


Figure 9



#### TYPICAL CHARACTERISTICS

V<sub>O</sub> - Output Voltage - V

# **RECEIVER OUTPUT VOLTAGE ENABLE VOLTAGE** $V_{\text{ID}} = 0.2 \text{ V}$ Load = 8 $k\Omega$ to GND $T_A = 25^{\circ}C$ $V_{CC} = 5.25 \text{ V}$ Vo - Output Voltage - V $V_{CC} = 4.75 \text{ V}$ $V_{CC} = 5 V$ 1 0 0.5 1.5 2.5 V<sub>I</sub> - Enable Voltage - V Figure 10

RECEIVER OUTPUT VOLTAGE
vs
ENABLE VOLTAGE

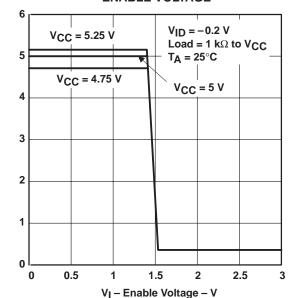
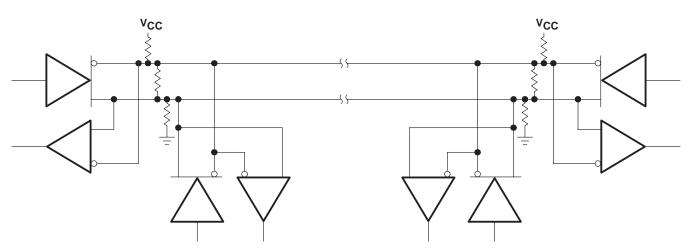


Figure 11

#### **APPLICATION INFORMATION**



**Figure 12. Typical Application Circuit** 

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